

P-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY

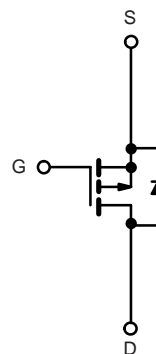
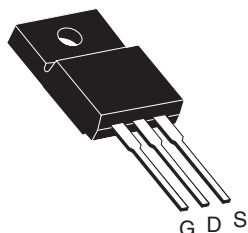
| V_{DS} (V) | $R_{DS(on)}$ (Ω) | I_D (A) ^a |
|--------------|----------------------------|------------------------|
| - 30 | 0.011 at $V_{GS} = -10$ V | 55 |
| | 0.013 at $V_{GS} = -4.5$ V | 50 |

FEATURES

- Compliant to RoHS Directive 2002/95/EC


 Available
RoHS*
 COMPLIANT

TO-220 FULLPAK



P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS ($T_C = 25^\circ\text{C}$, unless otherwise noted)

| Parameter | Symbol | Limit | Unit |
|--|---|----------------|------------------|
| Gate-Source Voltage | V_{GS} | ± 20 | V |
| Continuous Drain Current ($T_J = 175^\circ\text{C}$) | I_D | -55^a | A |
| | | -45 | |
| Pulsed Drain Current | I_{DM} | -260 | |
| Avalanche Current | I_{AR} | -55 | |
| Repetitive Avalanche Energy ^b | E_{AR} | 190 | mJ |
| Power Dissipation | $T_C = 25^\circ\text{C}$ (TO-220F) | 45^d | W |
| | $T_A = 25^\circ\text{C}$ (TO-220F) ^c | 3.75 | |
| Operating Junction and Storage Temperature Range | T_J, T_{stg} | -55 to 175 | $^\circ\text{C}$ |

THERMAL RESISTANCE RATINGS

| Parameter | Symbol | Limit | Unit |
|---------------------|------------|-------|--------------------|
| Junction-to-Ambient | R_{thJA} | 40 | $^\circ\text{C/W}$ |
| | | 62.5 | |
| Junction-to-Case | R_{thJC} | 0.8 | |

Notes:

a. Package limited.

b. Duty cycle $\leq 1\%$.

c. When mounted on 1" square PCB (FR-4 material).

d. See SOA curve for voltage derating.

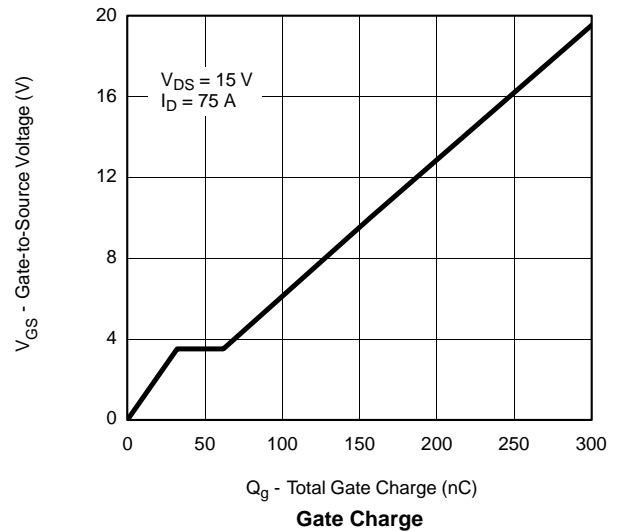
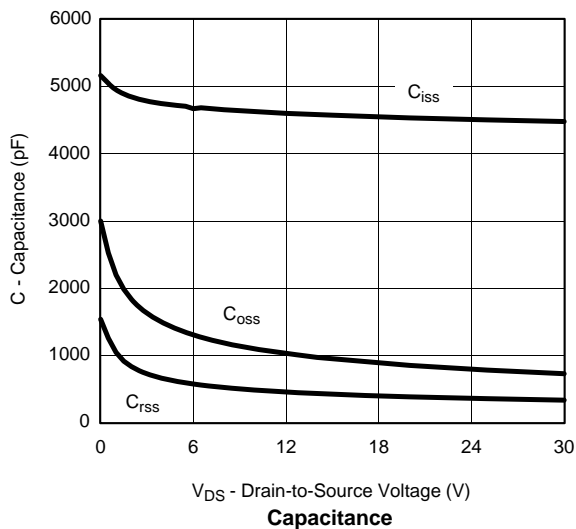
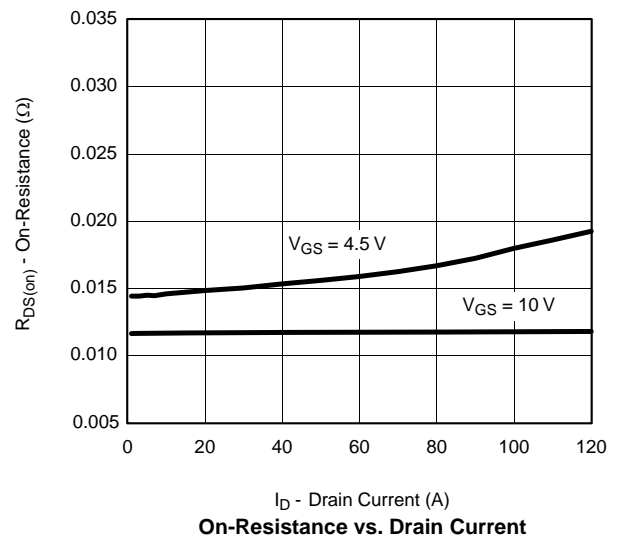
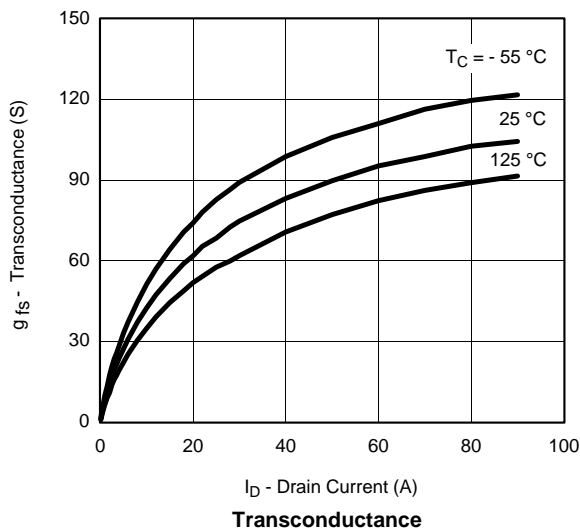
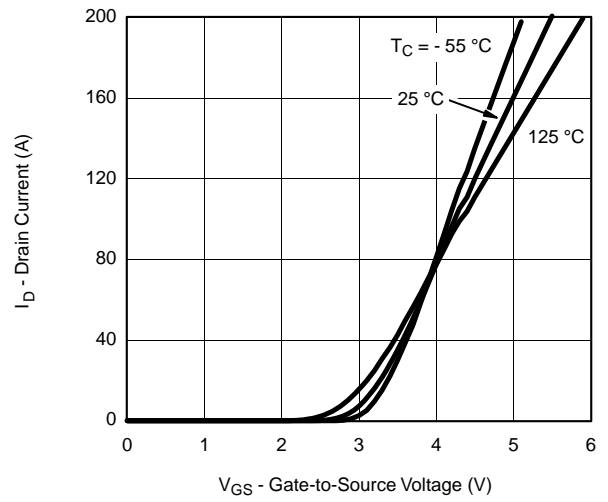
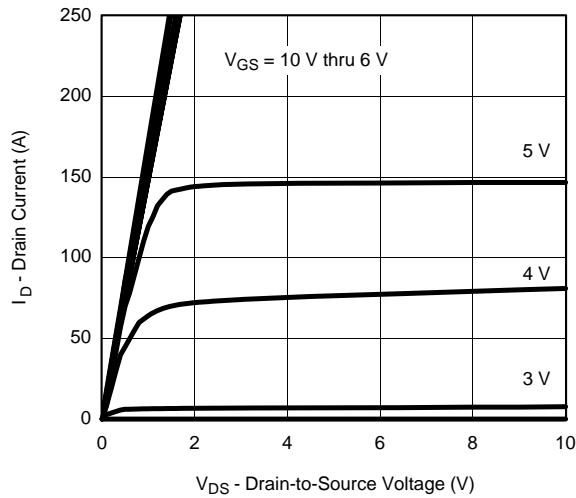
* Pb containing terminations are not RoHS compliant, exemptions may apply.

| SPECIFICATIONS (T _J = 25 °C, unless otherwise noted) | | | | | | |
|--|----------------------|--|-------|-------|-------|------|
| Parameter | Symbol | Test Conditions | Min. | Typ. | Max. | Unit |
| Static | | | | | | |
| Drain-Source Breakdown Voltage | V _{DS} | V _{GS} = 0 V, I _D = - 250 μA | - 30 | | | V |
| Gate Threshold Voltage | V _{GS(th)} | V _{DS} = V _{GS} , I _D = - 250 μA | - 1 | | - 3 | |
| Gate-Body Leakage | I _{GSS} | V _{DS} = 0 V, V _{GS} = ± 20 V | | | ± 100 | nA |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{DS} = - 30 V, V _{GS} = 0 V | | | - 1 | μA |
| | | V _{DS} = - 30 V, V _{GS} = 0 V, T _J = 125 °C | | | - 50 | |
| | | V _{DS} = - 30 V, V _{GS} = 0 V, T _J = 175 °C | | | - 250 | |
| On-State Drain Current ^a | I _{D(on)} | V _{DS} = - 5 V, V _{GS} = - 10 V | - 120 | | | A |
| Drain-Source On-State Resistance ^a | R _{DS(on)} | V _{GS} = - 10 V, I _D = - 30 A | | 0.011 | | Ω |
| | | V _{GS} = - 10 V, I _D = - 30 A, T _J = 125 °C | | 0.015 | | |
| | | V _{GS} = - 10 V, I _D = - 30 A, T _J = 175 °C | | 0.019 | | |
| | | V _{GS} = - 4.5 V, I _D = - 20 A | | 0.013 | | |
| Forward Transconductance ^a | g _{fs} | V _{DS} = - 15 V, I _D = - 75 A | 20 | | | S |
| Dynamic ^b | | | | | | |
| Input Capacitance | C _{iss} | V _{GS} = 0 V, V _{DS} = - 25 V, f = 1 MHz | | 4500 | | pF |
| Output Capacitance | C _{oss} | | | 765 | | |
| Reversen Transfer Capacitance | C _{rss} | | | 315 | | |
| Total Gate Charge ^c | Q _g | V _{DS} = - 15 V, V _{GS} = - 10 V, I _D = - 75 A | | 80 | 120 | nC |
| Gate-Source Charge ^c | Q _{gs} | | | 20 | | |
| Gate-Drain Charge ^c | Q _{gd} | | | 15 | | |
| Turn-On Delay Time ^c | t _{d(on)} | V _{DD} = - 15 V, R _L = 0.2 Ω I _D ≡ - 75 A, V _{GEN} = - 10 V, R _g = 2.5 Ω | | 25 | 40 | ns |
| Rise Time ^c | t _r | | | 225 | 360 | |
| Turn-Off Delay Time ^c | t _{d(off)} | | | 150 | 240 | |
| Fall Time ^c | t _f | | | 210 | 340 | |
| Source-Drain Diode Ratings and Characteristics ^b (T _C = 25 °C) | | | | | | |
| Continuous Current | I _S | | | | - 80 | A |
| Pulsed Current | I _{SM} | | | | - 240 | |
| Forward Voltage ^a | V _{SD} | I _F = - 75 A, V _{GS} = 0 V | | - 1.2 | - 1.5 | V |
| Reverse Recovery Time | t _{rr} | I _F = - 75 A, dI/dt = 100 A/μs | | 55 | 100 | ns |
| Peak Reverse Recovery Current | I _{RM(REC)} | | | 2.5 | 5 | A |
| Reverse Recovery Charge | Q _{rr} | | | 0.07 | 0.25 | μC |

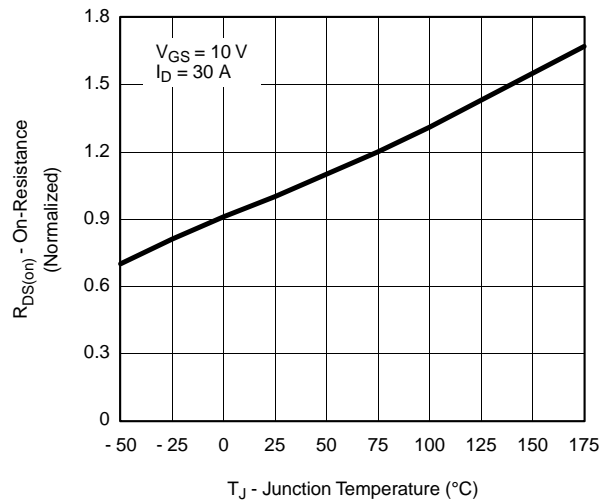
Notes:

- a. Pulse test; pulse width $\leq 300\text{ }\mu\text{s}$, duty cycle $\leq 2\%$.
 b. Guaranteed by design, not subject to production testing.
 c. Independent of operating temperature.

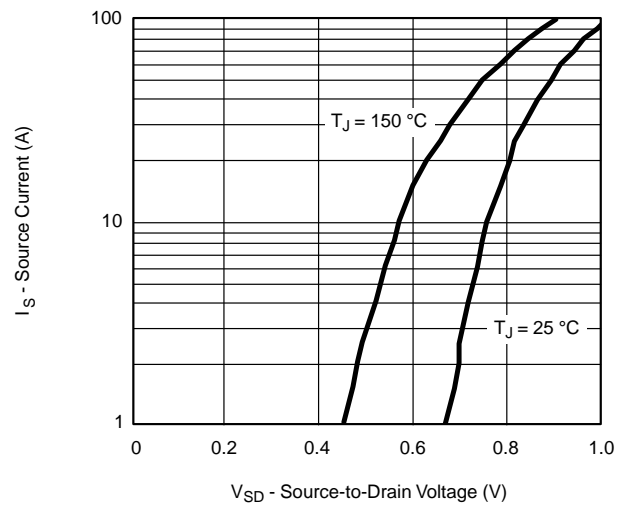
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)


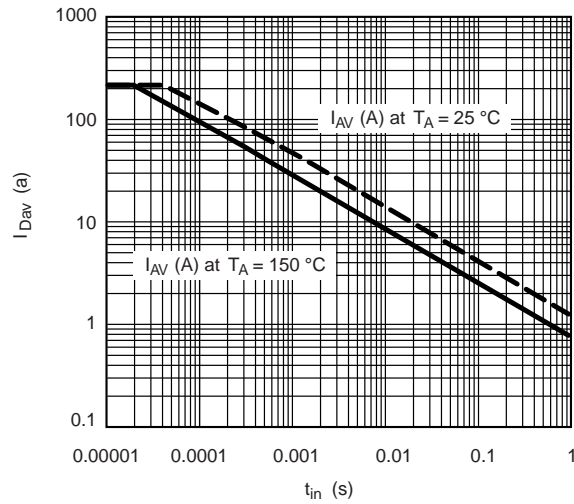
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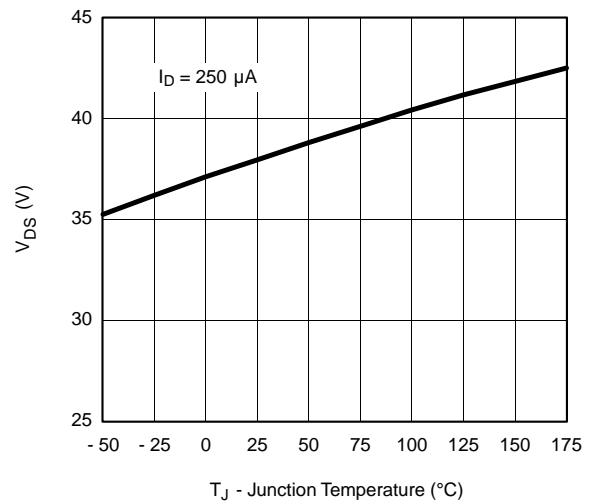
On-Resistance vs. Junction Temperature



Source-Drain Diode Forward Voltage

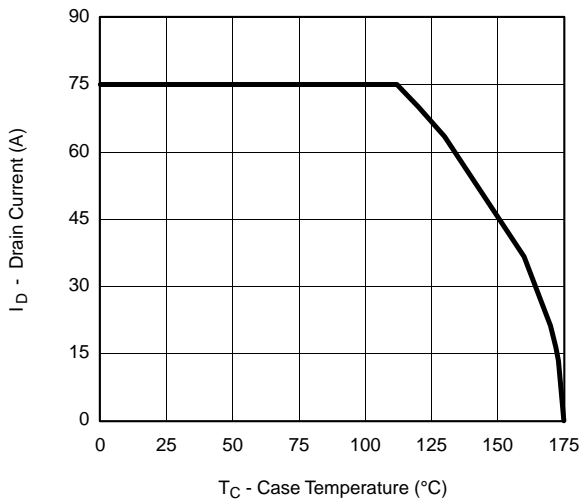


Avalanche Current vs. Time

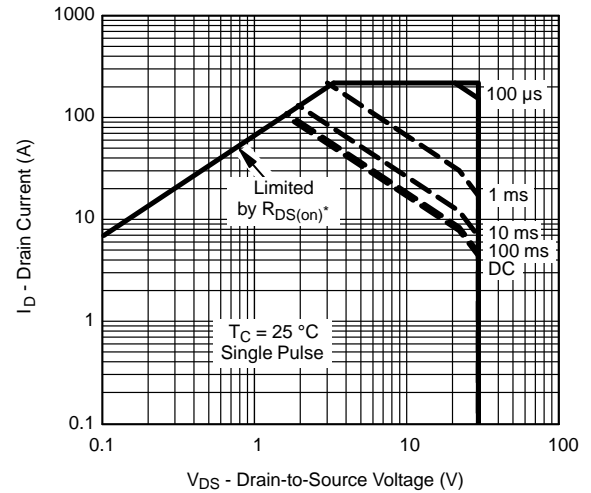


**Drain Source Breakdown
vs. Junction Temperature**

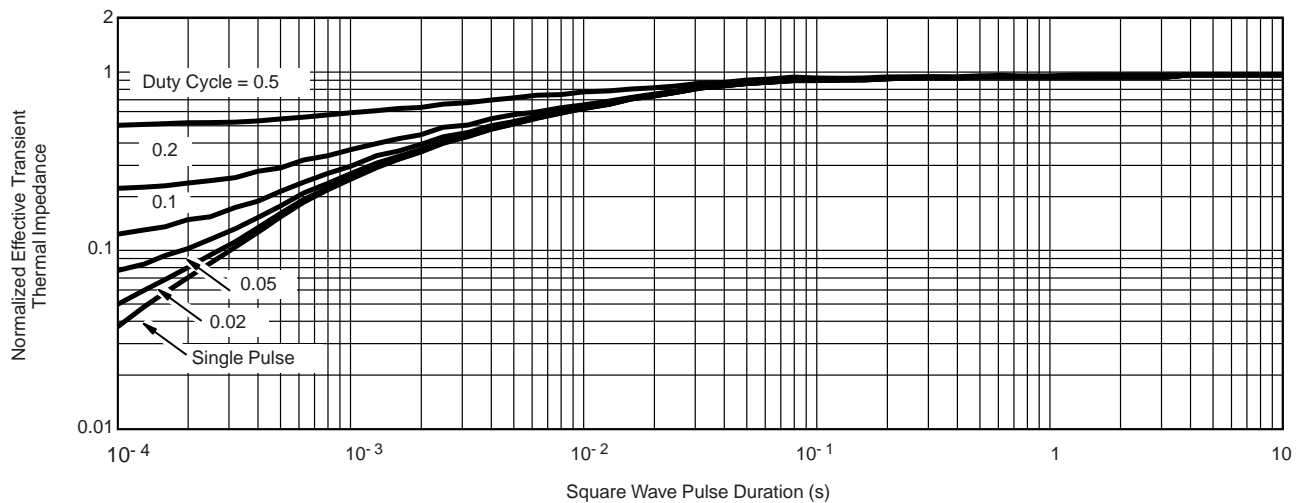
THERMAL RATINGS



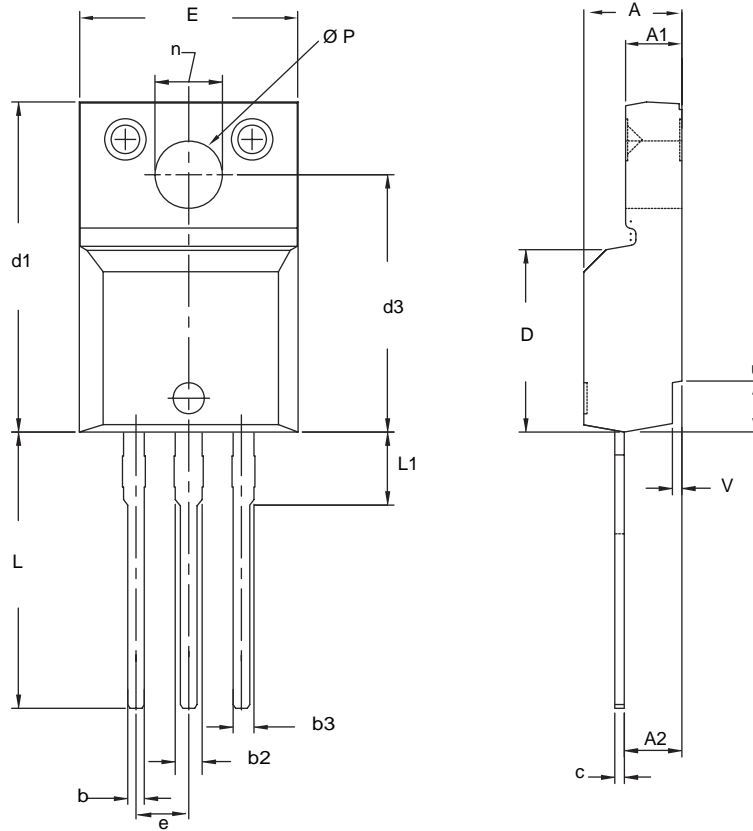
Maximum Avalanche and Drain Current vs. Case Temperature



Safe Operating Area



Normalized Thermal Transient Impedance, Junction-to-Case

TO-220 FULLPAK

| DIM. | MILLIMETERS | | INCHES | |
|------|-------------|--------|-----------|-------|
| | MIN. | MAX. | MIN. | MAX. |
| A | 4.570 | 4.830 | 0.180 | 0.190 |
| A1 | 2.570 | 2.830 | 0.101 | 0.111 |
| A2 | 2.510 | 2.850 | 0.099 | 0.112 |
| b | 0.622 | 0.890 | 0.024 | 0.035 |
| b2 | 1.229 | 1.400 | 0.048 | 0.055 |
| b3 | 1.229 | 1.400 | 0.048 | 0.055 |
| c | 0.440 | 0.629 | 0.017 | 0.025 |
| D | 8.650 | 9.800 | 0.341 | 0.386 |
| d1 | 15.88 | 16.120 | 0.622 | 0.635 |
| d3 | 12.300 | 12.920 | 0.484 | 0.509 |
| E | 10.360 | 10.630 | 0.408 | 0.419 |
| e | 2.54 BSC | | 0.100 BSC | |
| L | 13.200 | 13.730 | 0.520 | 0.541 |
| L1 | 3.100 | 3.500 | 0.122 | 0.138 |
| n | 6.050 | 6.150 | 0.238 | 0.242 |
| Ø P | 3.050 | 3.450 | 0.120 | 0.136 |
| u | 2.400 | 2.500 | 0.094 | 0.098 |
| v | 0.400 | 0.500 | 0.016 | 0.020 |

ECN: X09-0126-Rev. B, 26-Oct-09
 DWG: 5972

Notes

1. To be used only for process drawing.
2. These dimensions apply to all TO-220, FULLPAK leadframe versions 3 leads.
3. All critical dimensions should C meet $C_{pk} > 1.33$.
4. All dimensions include burrs and plating thickness.
5. No chipping or package damage.

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